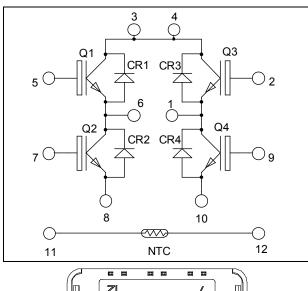
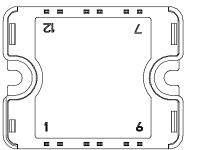


Full - Bridge High speed Trench + Field Stop IGBT4 Power Module





Pins 3/4 must be shorted together

# APTGLQ25H120T1G

### $V_{CES} = 1200V$ $I_{C} = 25A$ @ Tc = 80°C

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- High speed Trench + Field Stop IGBT 4 Technology
  - Low voltage drop
  - Low leakage current
  - Low switching losses
- Very low stray inductance
- Internal thermistor for temperature monitoring

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS Compliant

### All ratings @ T<sub>i</sub> = 25°C unless otherwise specified

### Absolute maximum ratings (per IGBT)

Symbol	Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Voltage		1200	V
т	Continuous Collector Current $\frac{T_{C} = 25^{\circ}C}{T_{C} = 80^{\circ}C}$	$T_C = 25^{\circ}C$	50	
I <sub>C</sub>		$T_C = 80^{\circ}C$	25	Α
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	100	
$V_{GE}$	Gate – Emitter Voltage		$\pm 20$	V
P <sub>D</sub>	Power Dissipation		165	W

These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

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### Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				50	μA
V	Collector Emitter Saturation Voltage	$ \begin{array}{c} V_{GE} = 15V \\ I_C = 25A \end{array} \qquad \begin{array}{c} T_j = 25^{\circ}C \\ T_j = 150^{\circ}C \end{array} $	$T_j = 25^{\circ}C$	1.78	2.05	2.42	V
V <sub>CE(sat)</sub>			$T_{j} = 150^{\circ}C$		2.6		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 0.85 \text{ mA}$		5.3	5.8	6.3	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				150	nA

### Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		1430		
Coes	Output Capacitance	$V_{CE} = 25V$		95		pF
Cres	Reverse Transfer Capacitance	f = 1 MHz		75		
Q <sub>G</sub>	Gate charge	$V_{GE} = 15V, I_C = 25A$ $V_{CE} = 960V$		115		nC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		27		
Tr	Rise Time	$V_{GE} = \pm 15 V$		41		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_C = 25A$		277		ns
$T_{\rm f}$	Fall Time	$R_G = 19\Omega$		17		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (150°C)		26		
Tr	Rise Time	$V_{GE} = \pm 15V$		35		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_C = 25A$		347		ns
$T_{\rm f}$	Fall Time	$R_G = 19\Omega$		50		
Eon	Turn on Energy	$ \begin{array}{c} V_{GE} = \pm 15V \\ V_{Bus} = 600V \end{array}  T_{j} = 150^{\circ}C \\ \end{array} $		2.4		mI
E <sub>off</sub>	Turn off Energy	$\begin{array}{c} I_{\rm C} = 25 A \\ R_{\rm G} = 19 \Omega \end{array} \qquad T_{\rm j} = 150^{\circ} {\rm C} \end{array}$		1.4		mJ
I <sub>sc</sub>	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 600V$ $t_p \le 10\mu s$ ; $T_j = 150^{\circ}C$		90		А
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.9	°C/W

### Reverse diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage					1200	V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =1200V				100	μA
$I_F$	DC Forward Current		$Tc = 80^{\circ}C$		30		Α
$\mathbf{V}_{\mathrm{F}}$		$I_{\rm F} = 30 {\rm A}$			2.6	3.1	
	Diode Forward Voltage	$I_F = 60A$		3.2		V	
		$I_F = 30A$	$T_{j} = 125^{\circ}C$		1.8		
t			$T_j = 25^{\circ}C$		300		20
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 30A$ $V_R = 800V$	$T_{j} = 125^{\circ}C$		380		ns
0	Reverse Recovery Charge	$v_R = 800 v$ di/dt = 200 A/µs	$T_j = 25^{\circ}C$		360		nC
Q <sub>rr</sub>		· · ·	$T_{j} = 125^{\circ}C$		1700		ne
R <sub>thJC</sub>	Junction to Case Thermal Resistance					1.2	°C/W

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### Thermal and package characteristics

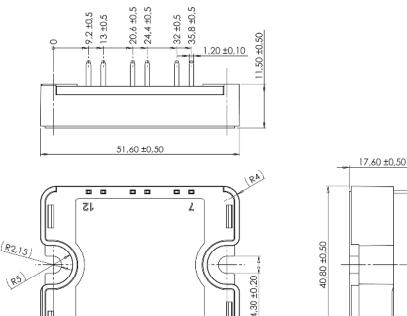
Symbol	Characteristic			Min	Max	Unit
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000		V
T <sub>J</sub>	Operating junction temperature range			-40	175	
T <sub>JOP</sub>	Recommended junction temperature under switching conditions			-40	T <sub>J</sub> max -25	°C
T <sub>STG</sub>	Storage Temperature Range			-40	125	C
T <sub>C</sub>	Operating Case Temperature			-40	125	
Torque	Mounting torque	To heatsink	M4	2	3	N.m
Wt	Package Weight				80	g

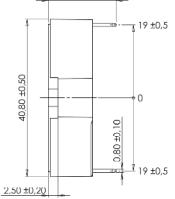
### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

Symbol	Characteristic				Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$						%
B <sub>25/85</sub>	$T_{25} = 298.15 \text{ K}$			3952		Κ
$\Delta B/B$		$T_C=100^{\circ}C$		4		%

$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

### Package outline (dimensions in mm)





See application note 1904 - Mounting Instructions for SP1 Power Modules on www.microsemi.com

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45 ±0,20

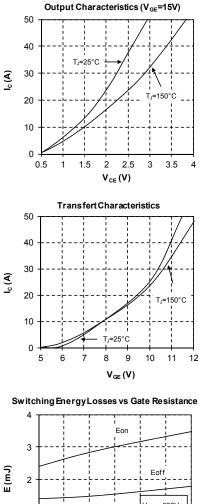
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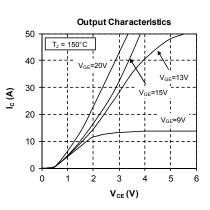
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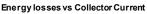


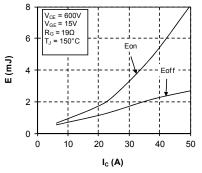
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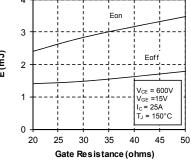
### **Typical Performance Curve**

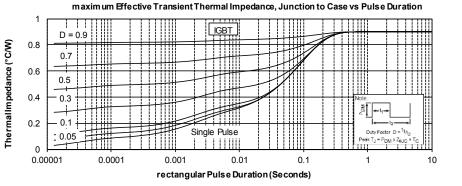






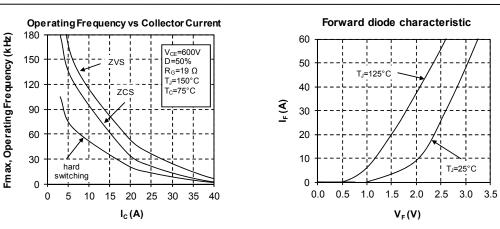




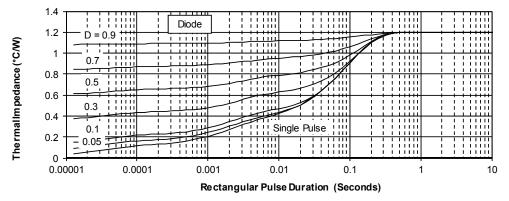




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maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



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